



March 2000

FDS5690

FDS5690

60V N-Channel PowerTrench[®] MOSFET

General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

Applications

- DC/DC converter
- Motor drives

Features

- 7 A, 60 V. $R_{DS(on)} = 0.028 \ \Omega \ @ V_{GS} = 10 \ V$ $R_{DS(on)} = 0.033 \ \Omega \ @ V_{GS} = 6 \ V.$
- Low gate charge (23nC typical).
- Fast switching speed.

5

6

7

8

High performance trench technology for extremely low R_{DS(ON)}.

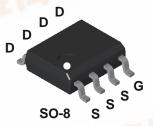
4

3

2

1

• High power and current handling capability.



SU-8 S Absolute Maximum Ratings T = 25% unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		60	V
V _{GSS}	Gate-Source Voltage		<u>+</u> 20	V
ID	Drain Current - Continuous	(Note 1a)	7	A
	- Pulsed		50	1000
PD	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.2	
		(Note 1c)	1	
T _J , T _{stg}	Ista Operating and Storage Junction Temperature Range		-55 to +150	۰C

Thermal Characteristics

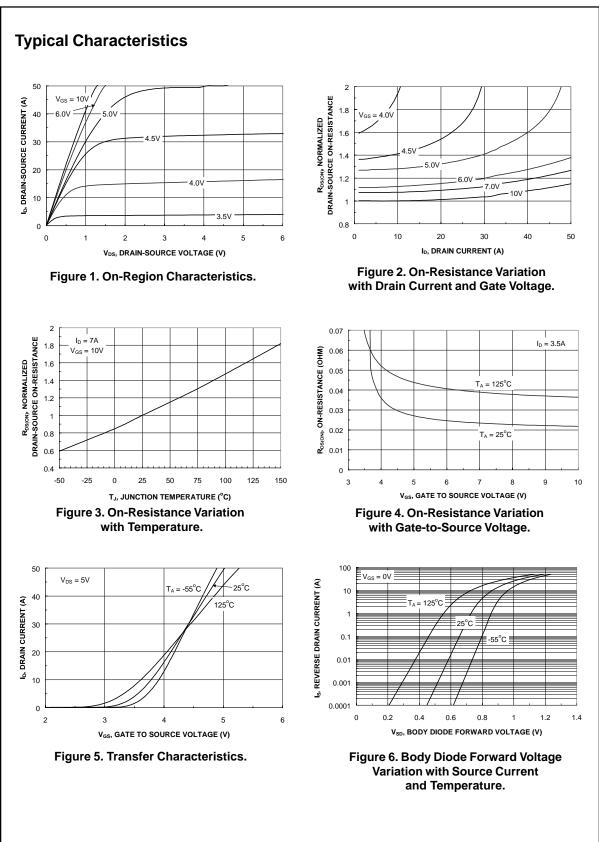
R _{ØJA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
R _{θJC}	Thermal Resistance, Junction-to-Case	(Note 1)	25	∘C/W

Package Outlines and Ordering Information

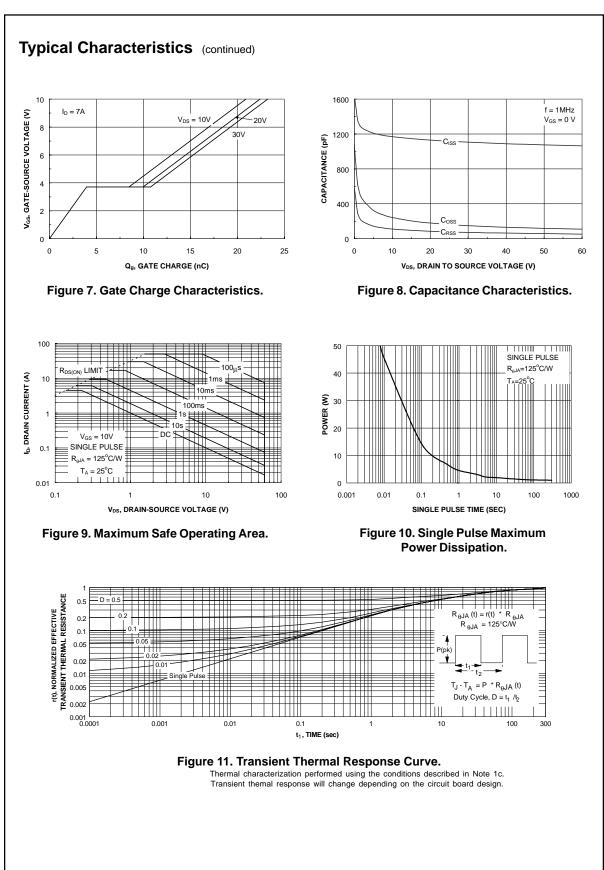
Device Marking	Device	Reel Size	Tape Width	Quantity
FDS5690	FDS5690	13"	12mm	2500 units

Off Chara		Test Conditions	Min	Тур	Max	Units
	octeristics		•			
	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = 250 \mu A$	60			V
-	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		57		mV/∘C
ss	Zero Gate Voltage Drain Current	$V_{DS} = 48 V, V_{GS} = 0 V$			1	μA
SSF	Gate-Body Leakage Current, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
SSR	Gate-Body Leakage Current, Reverse	$V_{GS} = -20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			-100	nA
n Chara	cteristics (Note 2)	·				
	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	2	2.5	4	V
√GS(th)	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25°C		-5.9		mV/∘C
DS(on)	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 7 \text{ A}$ $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 7 \text{ A}, \text{ T}_{J}=125^{\circ}\text{C}$ $V_{GS} = 6 \text{ V}, \text{ I}_{D} = 6.5 \text{ A}$		0.022 0.037 0.025	0.028 0.050 0.033	Ω
(on)	On-State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$	25			Α
FS	Forward Transconductance	V _{DS} = 10 V, I _D = 7 A		24		S
wnamia	Characteristics					
-	Input Capacitance	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$		1107		pF
	Output Capacitance	f = 1.0 MHz		149		pF
	Reverse Transfer Capacitance			72		pF
	·					
	Characteristics (Note 2)			10	40	
, ,	Turn-On Delay Time Turn-On Rise Time	$V_{DD} = 30 \text{ V}, \text{ I}_{D} = 1 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		10	18	ns
				9	18	ns
(-)	Turn-Off Delay Time			24	39	ns
	Turn-Off Fall Time			10	18	ns
	Total Gate Charge	$V_{DS} = 30 \text{ V}, \text{ I}_{D} = 7 \text{ A},$ $V_{GS} = 10 \text{ V},$		23	32	nC
5.	Gate-Source Charge			4		nC
gd	Gate-Drain Charge			6.8		nC
	urce Diode Characteristics and	•	I		0.4	
				0.75		
I _S	Maximum Continuous Drain-Source Dic Drain-Source Diode Forward Voltage	•		0.75	2.1 1.2	A V

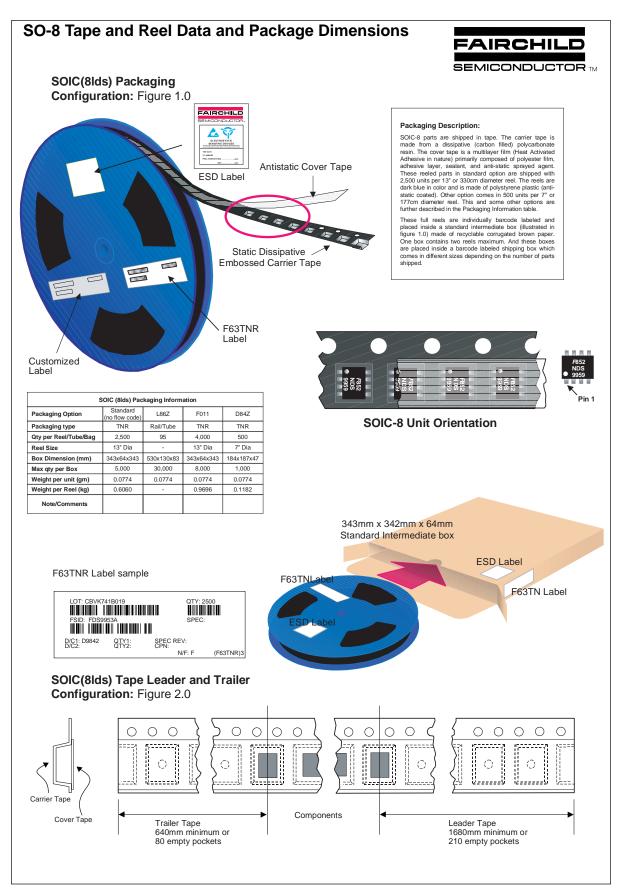
FDS5690

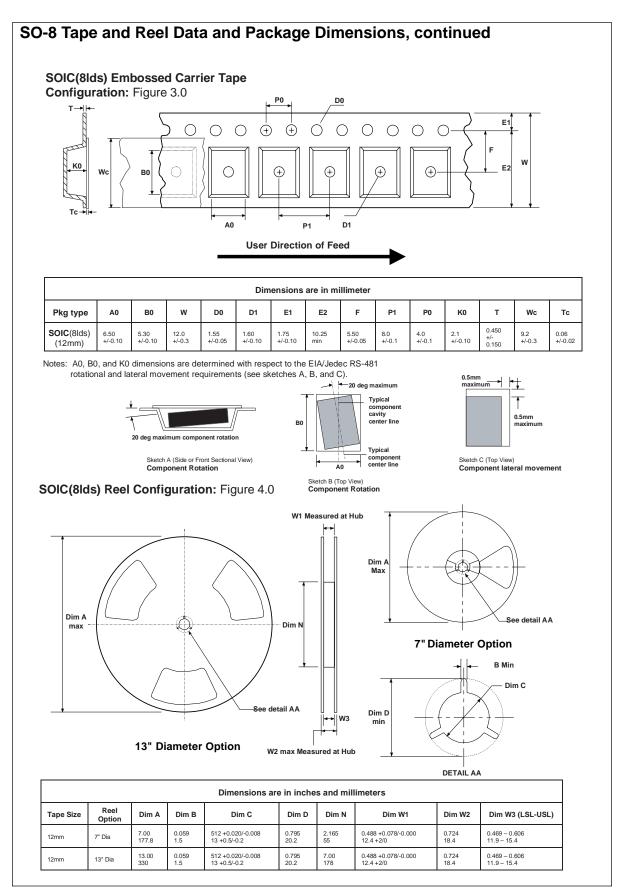


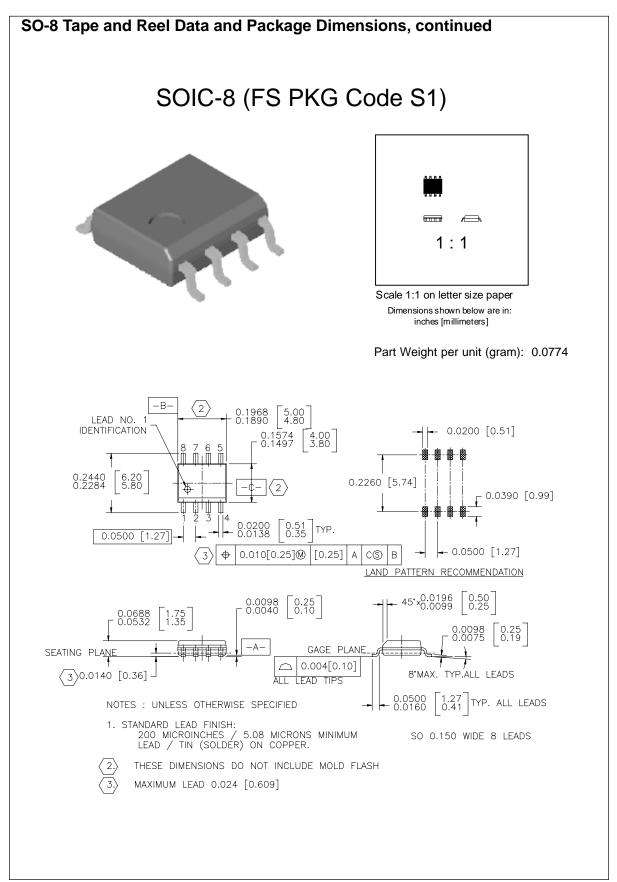
FDS5690



FDS5690







TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEx™	HiSeC™
Bottomless™	ISOPLANAR™
CoolFET™	MICROWIRE™
CROSSVOLT™	POP™
E²CMOS™	PowerTrench [®]
FACT™	QFET™
FACT Quiet Series™	QS™
FAST [®]	Quiet Series™
FASTr™	SuperSOT™-3
GTO™	SuperSOT™-6

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user. 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

SuperSOT[™]-8 SyncFET[™] TinyLogic[™] UHC[™] VCX[™]

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition			
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.			
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.			
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.			
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.			